

Reference

- [1] Kwon, Soo-Hun, Hyo-Jun Joo, and Hyuck-In Kwon. *Ceramics International* 44.17 (2018): 20883-20889.
- [2] Panda, Sri Aurobindo, et al. *physica status solidi (a)*: 2400698.
- [3] Pan, Ling, et al. *Materials Letters* 257 (2019): 126737.
- [4] Kim, Hye-Mi, et al. *ACS Applied Materials & Interfaces* 13.26 (2021): 30818-30825.
- [5] Chae, Myeong Gil, et al. *Applied Surface Science* 547 (2021): 148758.
- [6] Mameli, Alfredo, et al. *Advanced Materials Interfaces* 9.9 (2022): 2101278.

➤ XPS result of p-type SnO thin film and transfer curve of its TFT

